## In situ HR-TEM characterizations on individual carbon nanotubes during its manipulation, deformation and growth

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Investigating the physical and chemical properties of individual nanostructures has long been endeavored with the atomic configurations. Although the measurements of the structural and electronic transport properties of carbon nanotubes were previous preformed in TEM, the resolution of the image and the stability of the specimen holder were relative poor. *In situ* HR-TEM studies with a higher spatial resolution have been just made possible by the advancement of the electron optics in TEM based on the aberration correctors (CEOS) and the development of more stable specimen holder (Nanofactory). In this talk, we will present a few examples of the *in situ* HR-TEM studies atomic defects (large vacancies) at the elevated temperatures [2], the catalytic enlargement of fullerenes [3], catalyst-free inner growth of single-wall carbon nanotubes [4], the growth mechanism of carbon onion [5], as well as the experimental demonstration of lip-lip interactions in multi-wall carbon nanotubes [6].

References

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FIG. 1. Two examples showing the seamlessly joining of two SWNTs (A-C) and DWNTs (D-F) which have nearly the same diameter and chirality. Scale bar = 5 nm.



FIG. 2. A time sequential TEM image for the catalyst-free growth of SWNT inside a DWNT. Scale bar = 5 nm.